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CONFIRMATION NO. 8707

SERIAL NUMBER 10/562,797	FILING or 371(c) DATE 12/29/2005 RULE	CLASS 324	GROUP ART UNIT 2829	ATTORNEY DOCKET NO. 500.45763X00	
APPLICANTS Susumu Kasukabe, Tokyo, JAPAN; Takeshi Yamamoto, Tokyo, JAPAN; ** CONTINUING DATA ***** This application is a 371 of PCT/JP04/09412 07/02/2004 ** FOREIGN APPLICATIONS ***** JAPAN 2003-189949 07/02/2003 ** IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 05/19/2006					
Foreign Priority claimed <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No 35 USC 119(a-d) conditions met <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No Verified and /RICHARD ISLA RODAS/ Acknowledged Examiner's Signature	<input type="checkbox"/> Met after Allowance RI Initials	STATE OR COUNTRY JAPAN	SHEETS DRAWINGS 12	TOTAL CLAIMS 23	INDEPENDENT CLAIMS 5
ADDRESS ANTONELLI, TERRY, STOUT & KRAUS, LLP 1300 NORTH SEVENTEENTH STREET SUITE 1800 ARLINGTON, VA 22209-3873 UNITED STATES					
TITLE Probe card and semiconductor testing device using probe sheet or probe card semiconductor device producing method					
FILING FEE RECEIVED 1450	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:		<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit		